

Features

- Supply Voltage: 4.5V to 36V
- Offset Voltage: $\pm 50\mu\text{V}$ Maximum
- Differential Input Voltage Range to Supply Rail, can Work as Comparator
- Input Rail to $-V_s$, Rail to Rail Output
- Drive any capacitive load
- Bandwidth: 6MHz, Slew Rate: 5V/ μs
- Excellent EMI Suppress Performance: 85dB at 1GHz
- Over-Temperature Protection
- Low Noise: 8 nV/ $\sqrt{\text{Hz}}$ at 1kHz
- 2kV HBM, 1kV CDM, 500mA Latch Up
- -40°C to 125°C Operation Temperature Range

Applications

- Instrumentation
- Active Filters, ASIC Input or Output Amplifier
- Sensor Interface
- Industrial Control

Description

The TP27 is newest high supply voltage amplifiers with low offset, low power and stable high frequency response. It incorporates 3PEAK's proprietary and patented design techniques to achieve very good AC performance with 6MHz bandwidth, 5V/ μs slew rate and low distortion. The input common-mode voltage range extends to V_- , and the outputs swing rail-to-rail. The TP27 family can be used as plug-in replacements for many commercially available op-amps to reduce power and improve input/output range and performance. The combination of features makes the TP27 ideal choices for industrial control, instrumentation.

| | TP07A | TP17 | TP27 |
|---------------------------------------|--------------|-------------|-------------|
| V_{os} 25°C, µV | ± 150 | ± 100 | ± 50 |
| V_{os} -40 to 85°C, µV | ± 500 | ± 400 | ± 70 |
| GBW, MHz | 1 | 6 | 6 |
| I_q, mA | 1.5 | 2 | 1.6 |

Pin Configuration

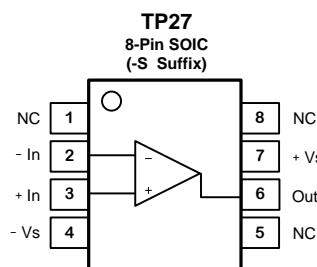


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Revision History

| Date | Revision | Notes |
|------------|----------|--|
| 2018/12/21 | Rev.Pre | Pre-Release Version |
| 2019/9/11 | Rev.0 | Initial Version |
| 2020/8/1 | Rev.A | Correct typo in the header: 5MHz -> 6MHz, Add Test Figure |
| 2021/7/7 | Rev.A.1 | Update maximum rating: Input voltage: $(-V_S) - 0.3 \text{ to } (+V_S) + 0.3 \rightarrow (-V_S) - 0.3 \text{ to } 40 \text{ V}$ Differential Input Voltage : $(+V_S) - (-V_S) \rightarrow (-V_S) - (+V_S) \text{ to } (+V_S) - (-V_S)$ |

Order Information

| Order Number | Operating Temperature Range | Package | Marking Information | MSL | Transport Media, Quantity |
|--------------|-----------------------------|------------|---------------------|-----|---------------------------|
| TP27-SR | -40 to 125°C | 8-Pin SOIC | TP27 | 3 | Tape and Reel, 4000 |

Absolute Maximum Ratings ^{Note 1}

| Parameters | Rating |
|---|--|
| Supply Voltage, $(+V_S) - (-V_S)$ | 40 V |
| Input Voltage | $(-V_S) - 0.3$ to 40 V |
| Differential Input Voltage | $(-V_S) - (+V_S)$ to $(+V_S) - (-V_S)$ |
| Input Current: $+IN, -IN$ ^{Note 2} | $\pm 10\text{mA}$ |
| Output Voltage | $(-V_S) - 0.3$ to $(+V_S) + 0.3$ |
| Output Short-Circuit Duration ^{Note 3} | Infinite |
| Maximum Junction Temperature | 150°C |
| Operating Temperature Range | -40 to 125°C |
| Storage Temperature Range | -65 to 150°C |
| Lead Temperature (Soldering, 10 sec) | 260°C |

Note 1: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

Note 2: The inputs are protected by ESD protection diodes to negative power supply. If the input extends more than 300mV beyond the negative power supply, the input current should be limited to less than 10mA.

Note 3: A heat sink may be required to keep the junction temperature below the absolute maximum. This depends on the power supply voltage and how many amplifiers are shorted. Thermal resistance varies with the amount of PC board metal connected to the package. The specified values are for short traces connected to the leads.

ESD Rating

| Symbol | Parameter | Condition | Minimum Level | Unit |
|--------|--------------------------|------------------------|---------------|------|
| HBM | Human Body Model ESD | ANSI/ESDA/JEDEC JS-001 | 2 | kV |
| CDM | Charged Device Model ESD | ANSI/ESDA/JEDEC JS-002 | 1 | kV |
| LU | Latch Up | JESD 78, 25°C | 500 | mA |
| | | JESD 78, 125°C | 250 | mA |

Thermal Information

| Package Type | θ_{JA} | θ_{JC} | Unit |
|--------------|---------------|---------------|------|
| 8-Pin SOIC | 158 | 43 | °C/W |

Electrical Characteristics

All test condition is $V_S = 30V$, $T_A = 25^\circ C$, $R_L = 10k\Omega$, unless otherwise noted.

| Symbol | Parameter | Conditions | T_A | Min | Typ | Max | Unit |
|-----------------------|---------------------------------|---|----------------|------|------|------------|-------|
| Power Supply | | | | | | | |
| V_S | Supply Voltage Range | | | 4.5 | | 36 | V |
| I_Q | Quiescent Current per Amplifier | $V_S = 30V$ | | | 1.4 | 1.6 | mA |
| | | | -40°C to 125°C | | | 1.8 | mA |
| | Power Supply Rejection Ratio | $V_S = 5V$ | | | 1.2 | 1.5 | mA |
| | | | -40°C to 125°C | | | 1.7 | mA |
| PSRR | Power Supply Rejection Ratio | $V_S = 4.5V$ to 36V | | 125 | 140 | | dB |
| | | | -40°C to 125°C | 120 | | | dB |
| Input Characteristics | | | | | | | |
| V_{OS} | Input Offset Voltage | $V_S = 30V$, $V_{CM} = 15V$ | | -50 | | 50 | µV |
| | | | -40°C to 125°C | -70 | | 70 | µV |
| | | $V_S = 5V$, $V_{CM} = 2.5V$ | | -50 | | 50 | µV |
| | | | -40°C to 125°C | -70 | | 70 | µV |
| $V_{OS\ TC}$ | Input Offset Voltage Drift | | -40°C to 125°C | | 0.01 | 0.2 | µV/°C |
| I_B | Input Bias Current | | | | 100 | | pA |
| | | | -40°C to 125°C | | 100 | | pA |
| I_{OS} | Input Offset Current | | | | 100 | | pA |
| I_{IN} | Different Input Current | $V_S = 36V$, $V_{ID} = 36V$ | | | 10 | 100 | µA |
| | | | -40°C to 125°C | | | 120 | µA |
| C_{IN} | Input Capacitance | Differential Mode | | | 5 | | pF |
| | | Common Mode | | | 2.5 | | pF |
| Av | Open-loop Voltage Gain | $R_{LOAD} = 10k\Omega$, $V_{OUT} = 0.5V$ to 29.5 V | | 130 | 140 | | dB |
| | | | -40°C to 125°C | 125 | | | dB |
| V_{CMR} | Common-mode Input Voltage Range | | | (V-) | | (V+) - 1.5 | V |
| CMRR | Common Mode Rejection Ratio | $V_{CM} = 0V$ to 28.5V | | 125 | 140 | | dB |
| | | | -40°C to 125°C | 120 | | | dB |

| Output Characteristics | | | | | | | |
|------------------------|-------------------------------------|--|----------------|-----|--------|-----|----------------|
| | Output Swing from Positive Rail | $R_{LOAD} = 100k\Omega$ to $V_s/2$ | | | 10 | 15 | mV |
| | | | -40°C to 125°C | | | 30 | mV |
| | | $R_{LOAD} = 10k\Omega$ to $V_s/2$ | | | 75 | 100 | mV |
| | | | -40°C to 125°C | | | 180 | mV |
| | Output Swing from Negative Rail | $R_{LOAD} = 2k\Omega$ to $V_s/2$ | | | 400 | 500 | mV |
| | | | -40°C to 125°C | | | 750 | mV |
| | | $R_{LOAD} = 100k\Omega$ to $V_s/2$ | | | 3 | 5 | mV |
| | | | -40°C to 125°C | | | 10 | mV |
| | | $R_{LOAD} = 10k\Omega$ to $V_s/2$ | | | 25 | 35 | mV |
| | | | -40°C to 125°C | | | 60 | mV |
| | | $R_{LOAD} = 2k\Omega$ to $V_s/2$ | | | 130 | 150 | mV |
| | | | -40°C to 125°C | | | 300 | mV |
| I_{SC} | Output Short-Circuit Current | Source | | 60 | 95 | | mA |
| | | | -40°C to 85°C | 40 | | | mA |
| | | | -40°C to 125°C | 35 | | | mA |
| | | Sink | | 130 | 150 | | mA |
| | | | -40°C to 85°C | 100 | | | mA |
| | | | -40°C to 125°C | 85 | | | mA |
| | Capacitive Load Drive | | | | 1 | | nF |
| AC Specifications | | | | | | | |
| GBW | Gain-Bandwidth Product | | | | 6 | | MHz |
| SR | Slew Rate | $G = 1, 10V$ step | | 3 | 5 | | $V/\mu s$ |
| | | | -40°C to 125°C | 2.2 | | | $V/\mu s$ |
| t_{OR} | Overload Recovery | | | | 500 | | ns |
| t_s | Settling Time, 0.1% | $G = 1, 10V$ step | | | 7 | | μs |
| | Settling Time, 0.01% | | | | 12 | | μs |
| PM | Phase Margin | $R_L=10K, C_L=100pF$ | | | 70 | | ° |
| GM | Gain Margin | $R_L=10K, C_L=100pF$ | | | 15 | | dB |
| Noise Performance | | | | | | | |
| E_N | Input Voltage Noise | $f = 0.1Hz$ to $10Hz$ | | | 0.1 | | μV_{PP} |
| e_N | Input Voltage Noise Density | $f = 0.1Hz$ | | | 8 | | nV/\sqrt{Hz} |
| | | $f = 1kHz$ | | | 8 | | nV/\sqrt{Hz} |
| | | $f = 10kHz$ | | | 10 | | nV/\sqrt{Hz} |
| | | $f = 100kHz$ | | | 20 | | nV/\sqrt{Hz} |
| i_N | Input Current Noise | $f = 10kHz$ | | | 200 | | fA/\sqrt{Hz} |
| THD+N | Total Harmonic Distortion and Noise | $f = 1kHz, G = 1, R_L = 10k\Omega, V_{OUT} = 6V_{RMS}$ | | | 0.0005 | | % |

Typical Performance Characteristics

$V_S = \pm 15V$, $V_{CM} = 0V$, $R_L = 10k\Omega$, unless otherwise specified.

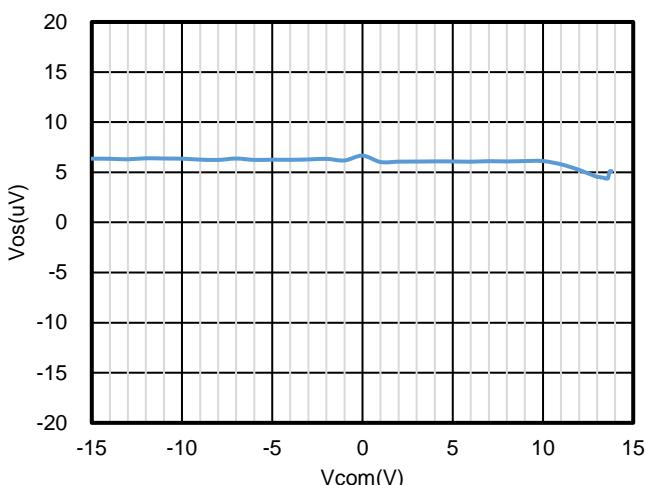


Figure 1. Offset Voltage vs. Common Mode Voltage

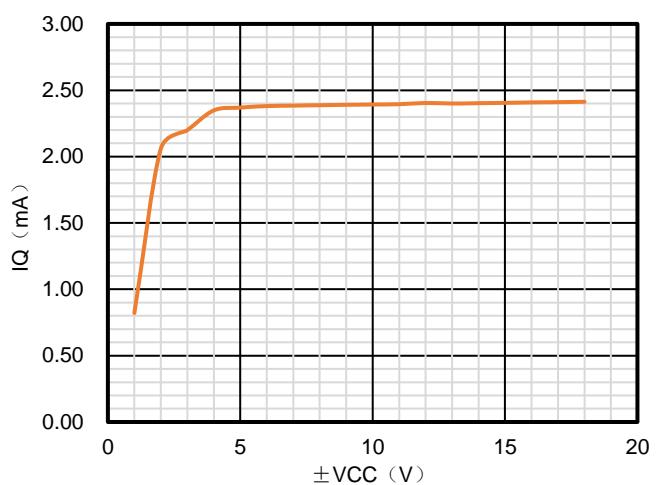


Figure 2. Iq vs. Supply Voltage

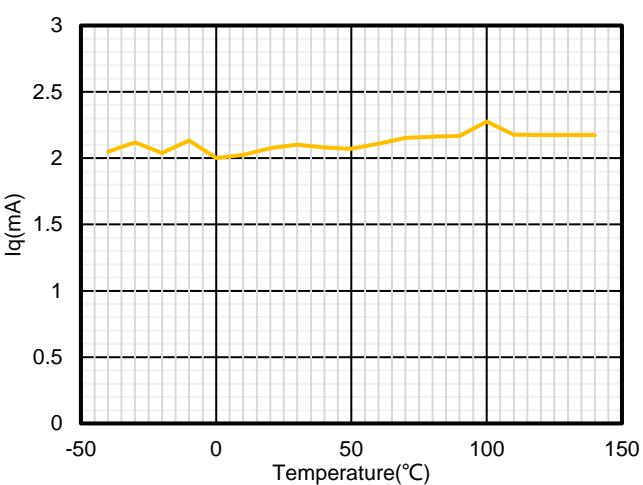


Figure 3. Iq vs. Temperature, +2.5V Supply

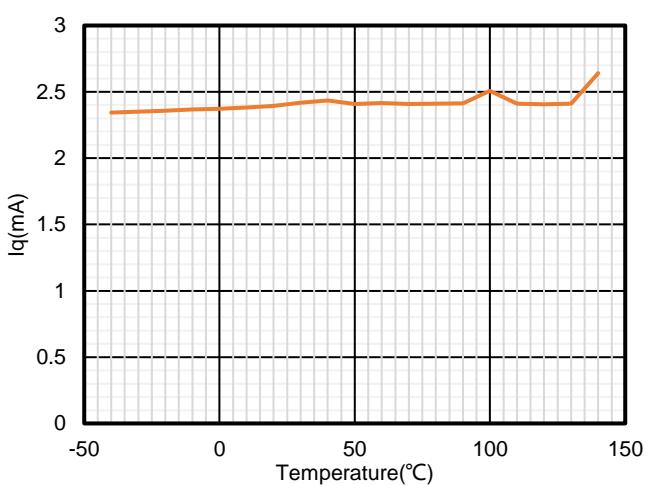


Figure 4. Iq vs. Temperature, +15V Supply

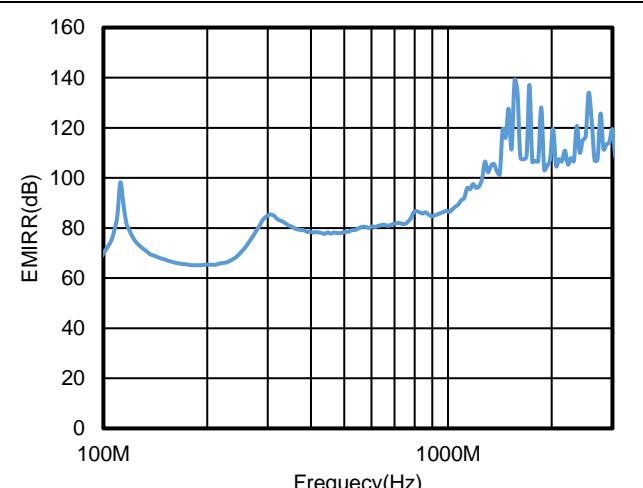


Figure 5. EMIRR vs. Frequency

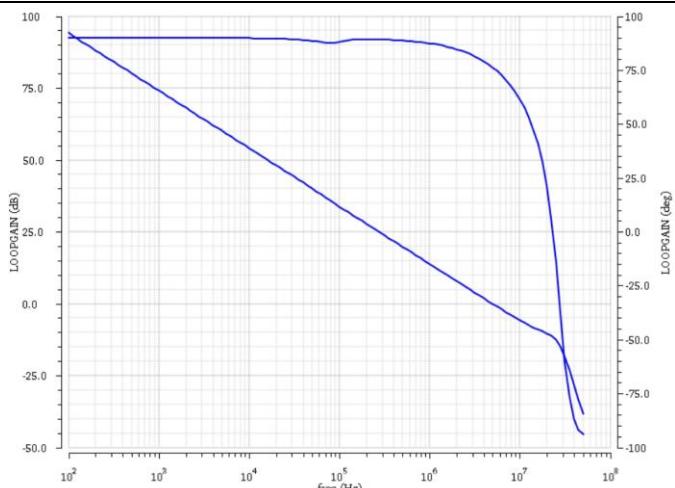


Figure 6. Open Loop Gain and Phase vs. Frequency

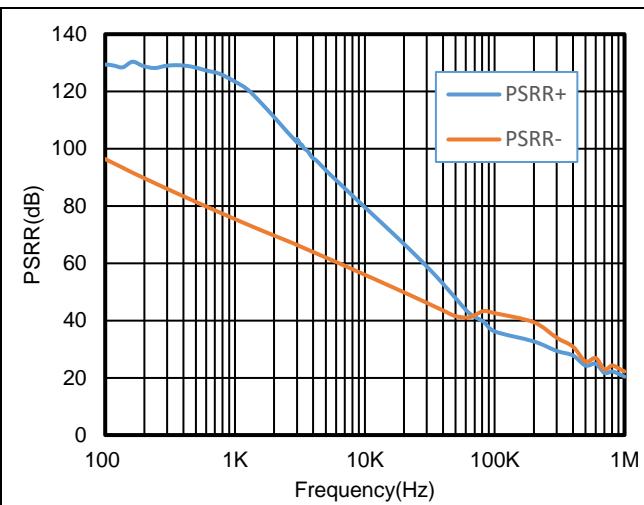


Figure 7. PSRR vs. Frequency

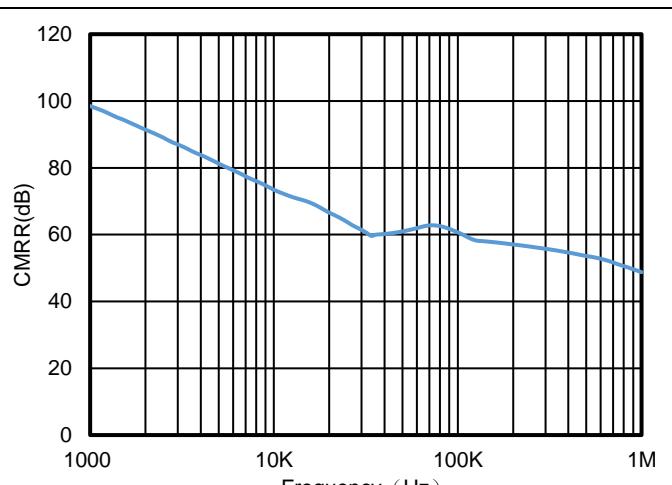
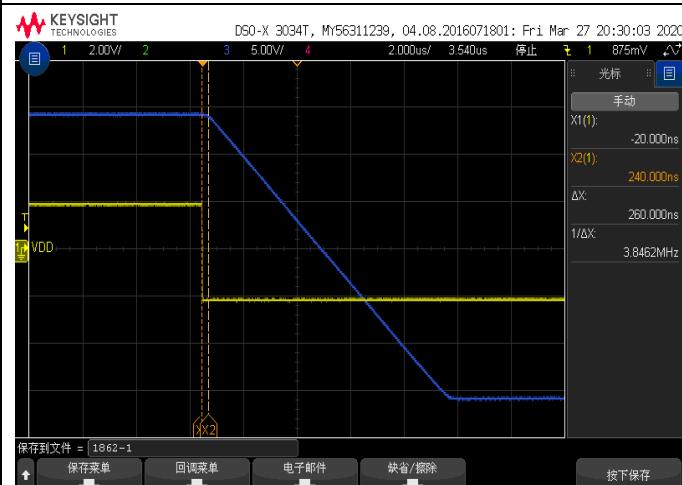


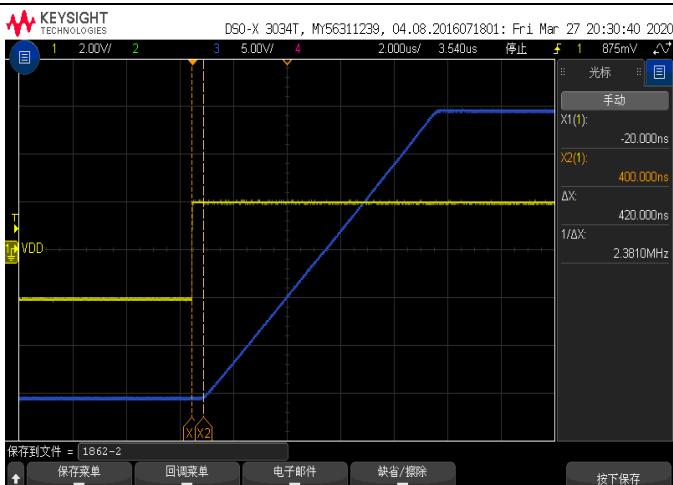
Figure 8. CMRR vs. Frequency



Time: 2us/div, Measure Time: 260ns

$R_L=2K$, $C_L=100pF$, $G=10$

Figure 9. Positive Overload Recovery



Time: 2us/div, Measure Time: 420ns

$R_L=2K$, $C_L=100pF$, $G=10$

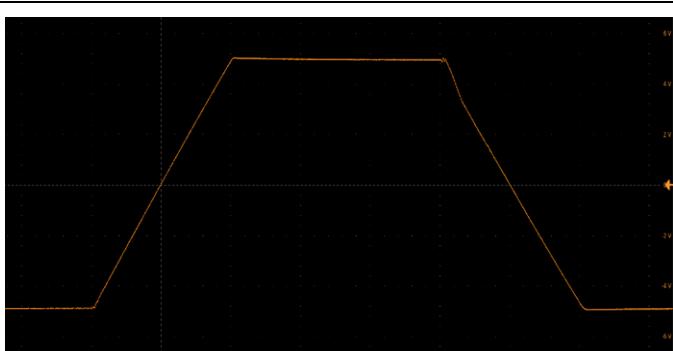
Figure 10. Negative Overload Recovery



Voltage: 50mV/div, Time: 2us/div

$R_L=2K$, $C_L=100pF$, $G=1$

Figure 11. 100mV Signal Step Response



Voltage: 2V/div, Time: 2μs/div

$R_L=2K$, $C_L=100pF$, $G=1$

Figure 12. 10V Signal Step Response

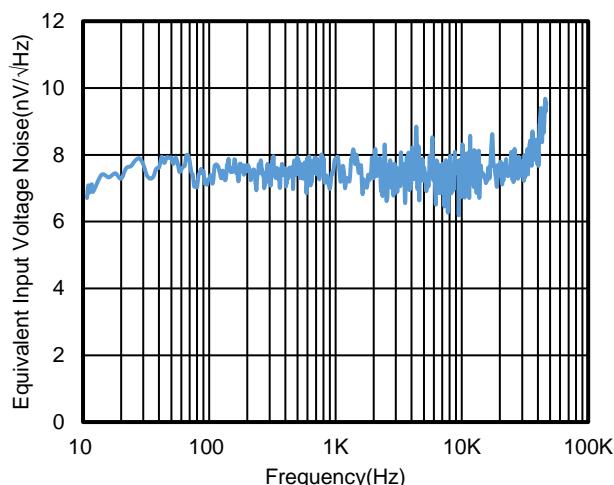


Figure 13. Voltage Noise Density vs. Frequency

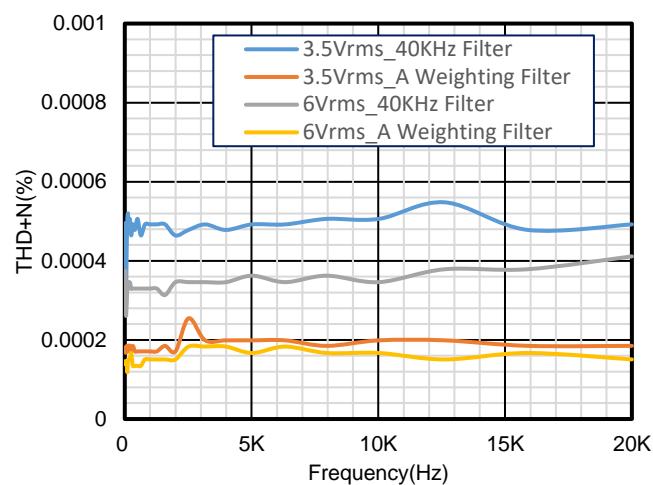


Figure 14. THD vs. Frequency, G = 1

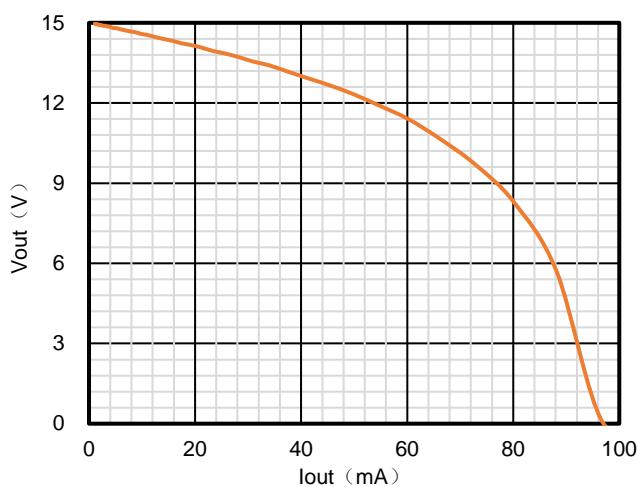


Figure 15. V_{OUT} vs. I_{OUT}, Source

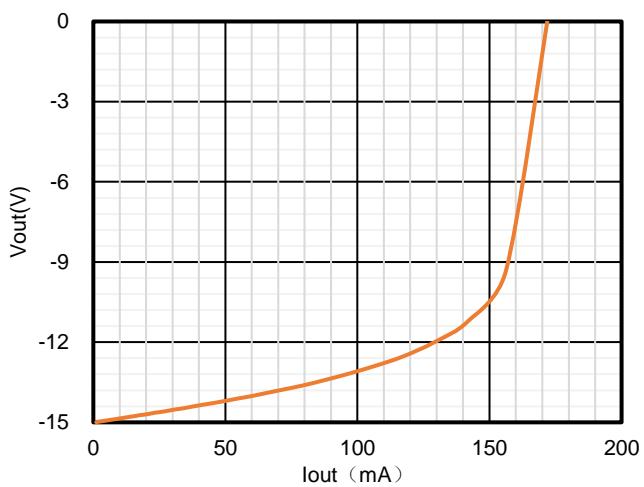
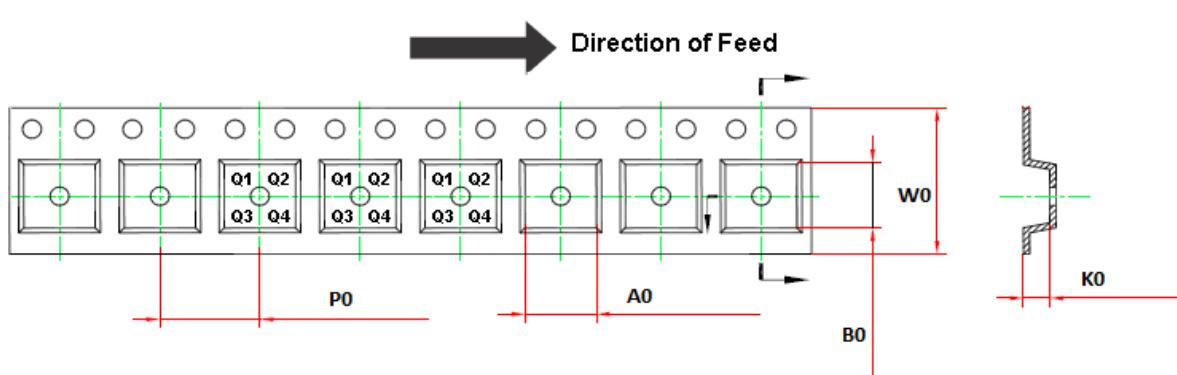
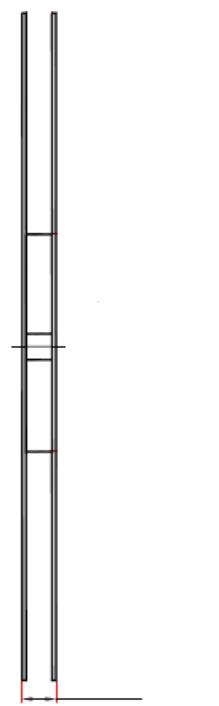
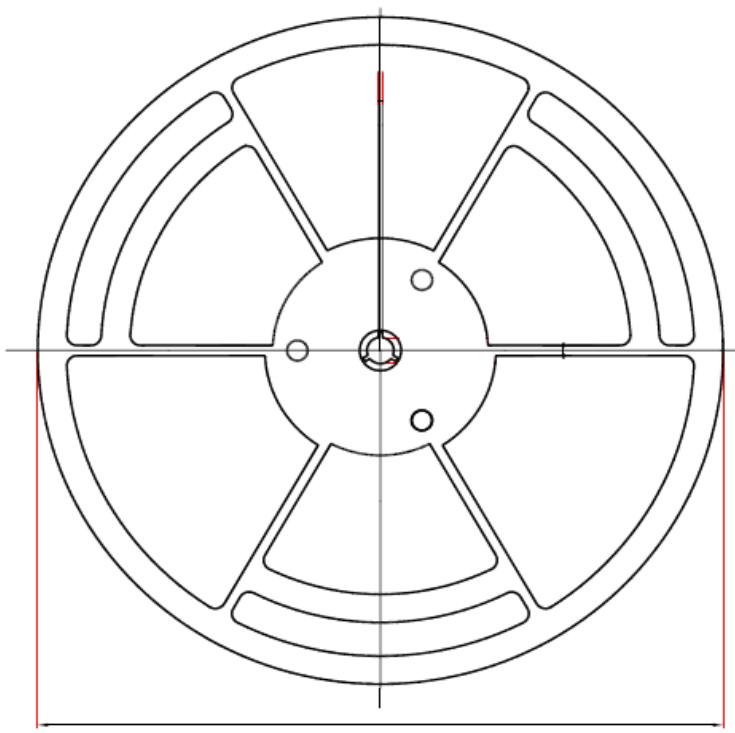


Figure 16. V_{OUT} vs. I_{OUT}, Sink

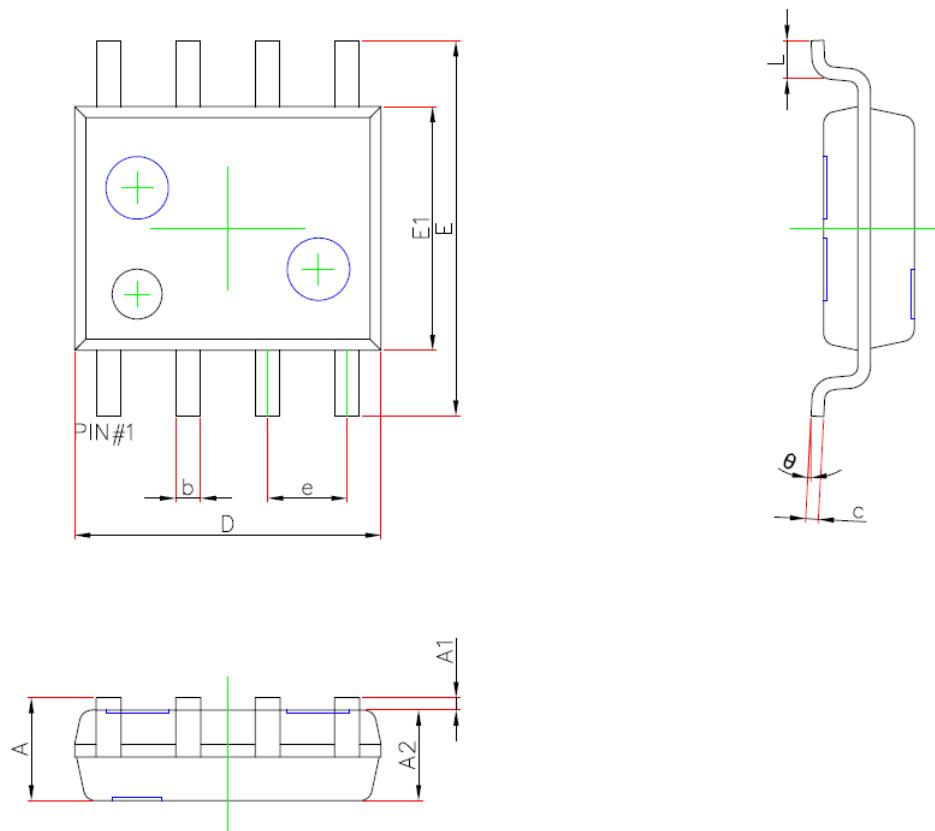
Tape and Reel Information



| Order Number | Package | D1 | W1 | A0 | B0 | K0 | P0 | W0 | Pin1 Quadrant |
|--------------|------------|-------|------|-----|-----|-----|-----|------|---------------|
| TP27-SR | 8-Pin SOIC | 330.0 | 17.6 | 6.4 | 5.4 | 2.1 | 8.0 | 12.0 | Q1 |

Package Outline Dimensions

SOIC-8



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|-------|----------------------|-------|
| | Min. | Max. | Min. | Max. |
| A | 1.350 | 1.750 | 0.053 | 0.069 |
| A1 | 0.100 | 0.250 | 0.004 | 0.010 |
| A2 | 1.350 | 1.550 | 0.053 | 0.061 |
| b | 0.330 | 0.510 | 0.013 | 0.020 |
| c | 0.170 | 0.250 | 0.007 | 0.010 |
| D | 4.700 | 5.100 | 0.185 | 0.201 |
| E | 5.800 | 6.200 | 0.228 | 0.244 |
| E1 | 3.800 | 4.000 | 0.150 | 0.157 |
| e | 1.270(BSC) | | 0.050(BSC) | |
| L | 0.400 | 0.800 | 0.016 | 0.031 |
| θ | 0° | 8° | 0° | 8° |

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